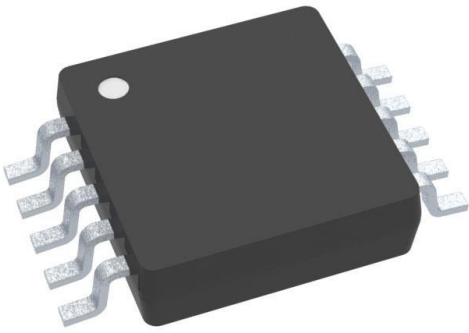


ADC161S626C1MM/NOPB Datasheet

www.digi-electronics.com



ADC161S626C1MM/NOPB

<https://www.DiGi-Electronics.com>

DiGi Electronics Part Number	ADC161S626C1MM/NOPB-DG
Manufacturer	Texas Instruments
Manufacturer Product Number	ADC161S626C1MM/NOPB
Description	IC ADC 16BIT SAR 10VSSOP
Detailed Description	16 Bit Analog to Digital Converter 1 Input 1 SAR 10-VSSOP



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DiGi is a global authorized distributor of electronic components.

Purchase and inquiry

Manufacturer Product Number:

ADC161S626C1MM/NOPB

Series:

microPOWER™

Number of Bits:

16

Number of Inputs:

1

Data Interface:

SPI

Ratio - S/H:ADC:

1:1

Architecture:

SAR

Voltage - Supply, Analog:

5V

Features:

-

Package / Case:

10-TFSOP, 10-MSOP (0.118", 3.00mm Width)

Mounting Type:

Surface Mount

Manufacturer:

Texas Instruments

Product Status:

Active

Sampling Rate (Per Second):

250k

Input Type:

Differential, Single Ended

Configuration:

S/H-ADC

Number of A/D Converters:

1

Reference Type:

External

Voltage - Supply, Digital:

2.7V ~ 5.5V

Operating Temperature:

-40°C ~ 85°C

Supplier Device Package:

10-VSSOP

Base Product Number:

ADC161S626

Environmental & Export classification

RoHS Status:

ROHS3 Compliant

REACH Status:

REACH Unaffected

HTSUS:

8542.39.0001

Moisture Sensitivity Level (MSL):

1 (Unlimited)

ECCN:

EAR99

ADC161S626 16-Bit, 50 to 250 kSPS, Differential Input, MicroPower ADC

1 Features

- 16-bit Resolution With No Missing Codes
- Ensured Performance from 50 to 250 kSPS
- $\pm 0.003\%$ Signal Span Accuracy
- Separate Digital Input/Output Supply
- True Differential Input
- External Voltage Reference Range of 0.5 V to V_A
- Zero-Power Track Mode with 0- μ sec Wake-up Delay
- Wide Input Common-mode Voltage Range of 0 V to V_A
- SPI/QSPI™/MICROWIRE™ Compatible Serial Interface
- Operating Temperature Range of -40°C to $+85^\circ\text{C}$
- Small VSSOP-10 Package
- Key Specifications
 - Conversion Rate 50 to 250 kSPS
 - DNL $+0.8 / -0.5$ LSB
 - INL ± 0.8 LSB
 - Offset Error Temp Drift $2.5 \mu\text{V}/^\circ\text{C}$
 - Gain Error Temp Drift $0.3 \text{ ppm}/^\circ\text{C}$
 - SNR 93.2 dBc
 - THD -104 dBc
 - Power Consumption
 - 10 kSPS, 5 V 0.24 mW
 - 200 kSPS, 5 V 5.3 mW
 - 250 kSPS, 5 V 5.8 mW
 - Power-Down, 5 V 10 μW

2 Applications

- Direct Sensor Interface
- I/O Modules
- Data Acquisition
- Portable Systems
- Motor Control
- Medical Instruments
- Instrumentation and Control Systems

3 Description

The ADC161S626 is a 16-bit successive-approximation register (SAR) Analog-to-Digital converter (ADC) with a maximum sampling rate of 250 kSPS. The ADC161S626 has a minimum signal span accuracy of $\pm 0.003\%$ over the temperature range of -40°C to $+85^\circ\text{C}$. The converter features a differential analog input with an excellent common-mode signal rejection ratio of 85 dB, making the ADC161S626 suitable for noisy environments.

The ADC161S626 operates with a single analog supply (V_A) and a separate digital input/output (V_{IO}) supply. V_A can range from 4.5 V to 5.5 V and V_{IO} can range from 2.7 V to 5.5 V. This allows a system designer to maximize performance and minimize power consumption by operating the analog portion of the ADC at a V_A of 5 V while interfacing with a 3.3-V controller. The serial data output is binary 2's complement and is SPI compatible.

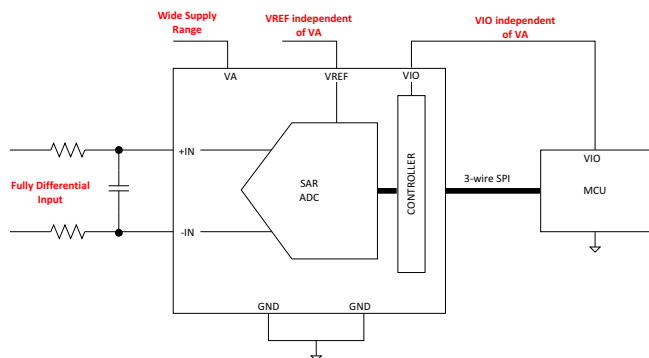
The performance of the ADC161S626 is ensured over temperature at clock rates of 1 MHz to 5 MHz and reference voltages of 2.5 V to 5.5 V. The ADC161S626 is available in a small 10-lead VSSOP package. The high accuracy, differential input, low power consumption, and small size make the ADC161S626 ideal for direct connection to bridge sensors and transducers in battery operated systems or remote data acquisition applications.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
ADC161S626	VSSOP (10)	3.00 mm x 3.00 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.

Typical Application Schematic



ADC161S626

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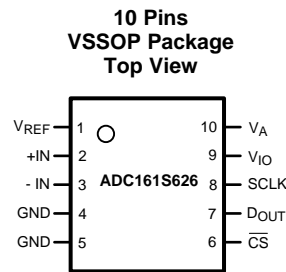
www.ti.com**Table of Contents**

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4 Revision History**Changes from Revision C (March 2013) to Revision D****Page**

- Added *Pin Configuration and Functions* section, *ESD Ratings* table, *Feature Description* section, *Device Functional Modes*, *Application and Implementation* section, *Power Supply Recommendations* section, *Layout* section, *Device and Documentation Support* section, and *Mechanical, Packaging, and Orderable Information* section **1**

5 Pin Configuration and Functions



Pin Functions

PIN		I/O	DESCRIPTION
NO.	NAME		
1	V_{REF}	I	Voltage Reference $0.5\text{ V} < V_{REF} < V_A$
2	+IN	I	Non-Inverting Input
3	-IN	I	Inverting Input
4	GND	Power	Ground
5	GND	Power	Ground
6	\overline{CS}	I	Chip Select Bar
7	D_{OUT}	O	Serial Data Output
8	SCLK	I	Serial Clock
9	V_{IO}	Power	Digital Input/Output Power $2.7\text{ V} < V_{REF} < 5.5\text{ V}$
10	V_A	Power	Analog Power $4.5\text{ V} < V_{REF} < 5.5\text{ V}$

6 Specifications

6.1 Absolute Maximum Ratings⁽¹⁾⁽²⁾⁽³⁾

	MIN	MAX	UNIT
Analog Supply Voltage V_A	-0.3	6.5	V
Digital I/O Supply Voltage V_{IO}	-0.3	6.5	V
Voltage on Any Analog Input Pin to GND	-0.3	$(V_A + 0.3)$	V
Voltage on Any Digital Input Pin to GND	-0.3	$(V_{IO} + 0.3)$	V
Input Current at Any Pin ⁽⁴⁾	-10	10	mA
Package Input Current ⁽⁴⁾	-50	50	mA
Power Consumption at $T_A = 25^\circ\text{C}$		See ⁽⁵⁾	
Junction Temperature		150	$^\circ\text{C}$
Storage temperature, T_{stg}	-65	150	$^\circ\text{C}$

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltages are measured with respect to GND = 0 V, unless otherwise specified.
- (3) If Military/Aerospace specified devices are required, please contact the TI Sales Office/ Distributors for availability and specifications.
- (4) When the input voltage at any pin exceeds the power supplies (that is, $V_{IN} < \text{GND}$ or $V_{IN} > V_A$), the current at that pin should be limited to 10 mA. The 50 mA maximum package input current rating limits the number of pins that can safely exceed the power supplies with an input current of 10 mA to five.
- (5) The absolute maximum junction temperature (T_{Jmax}) for this device is 150°C . The maximum allowable power dissipation is dictated by T_{Jmax} , the junction-to-ambient thermal resistance (θ_{JA}), and the ambient temperature (T_A), and can be calculated using the formula $P_{DMAX} = (T_{Jmax} - T_A)/\theta_{JA}$. The values for maximum power dissipation listed above will be reached only when the ADC161S626 is operated in a severe fault condition (e.g. when input or output pins are driven beyond the power supply voltages, or the power supply polarity is reversed). Such conditions should always be avoided.

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6.2 ESD Ratings

		VALUE	UNIT
$V_{(ESD)}$ Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2500	V
	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±1250	
	Machine model (MM)	250	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditionsover operating free-air temperature range (unless otherwise noted)⁽¹⁾

	MIN	MAX	UNIT
Operating Temperature Range	-40	85	°C
Supply Voltage, V_A	4.5	5.5	V
Supply Voltage, V_{IO}	2.7	5.5	V
Reference Voltage, V_{REF}	0.5	V_A	V
Analog Input Pins Voltage Range	0	V_A	V
Differential Analog Input Voltage	$-V_{REF}$	$+V_{REF}$	V
Input Common-Mode Voltage, V_{CM}	See Figure 44		
Digital Input Pins Voltage Range	0	V_{IO}	V
Clock Frequency	1	5	MHz

(1) All voltages are measured with respect to GND = 0V, unless otherwise specified.

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		ADC161S626	UNIT
		DGS	
		10 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	163	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	57	
$R_{\theta JB}$	Junction-to-board thermal resistance	82	
Ψ_{JT}	Junction-to-top characterization parameter	6	
Ψ_{JB}	Junction-to-board characterization parameter	81	

(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](#).

6.5 Converter Electrical Characteristics

The following specifications apply for $V_A = 4.5\text{ V}$ to 5.5 V , $V_{IO} = 2.7\text{ V}$ to 5.5 V , and $V_{REF} = 2.5\text{ V}$ to 5.5 V for $f_{SCLK} = 1\text{ MHz}$ to 4 MHz or $V_{REF} = 4.5\text{ V}$ to 5.5 V for $f_{SCLK} = 1\text{ MHz}$ to 5 MHz ; $f_{IN} = 20\text{ kHz}$, and $C_L = 25\text{ pF}$, unless otherwise noted. Maximum and minimum values apply for $T_A = T_{MIN}$ to T_{MAX} ; the typical values are tested at $T_A = 25^\circ\text{C}$.⁽¹⁾

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC CONVERTER CHARACTERISTICS						
	Resolution with No Missing Codes				16	Bits
DNL	Differential Non-Linearity		-1	-0.5/+0.8	+2	LSB
INL	Integral Non-Linearity		-2	±0.8	+2	LSB
OE	Offset Error	$V_{REF} = 2.5\text{ V}$	-1	-0.1	+1	mV
		$V_{REF} = 5\text{ V}$		-0.4		mV
OE _{DRIFT}	Offset Error Temperature Drift	$V_{REF} = 2.5\text{ V}$		3.7		µV/°C
		$V_{REF} = 5\text{ V}$		2.5		µV/°C
FSE	Positive Full-Scale Error		-0.03	-0.003	0.03	%FS
	Negative Full-Scale Error		-0.03	-0.002	0.03	%FS
GE	Positive Gain Error		-0.02	-0.002	0.02	%FS
	Negative Gain Error		-0.02	-0.0001	0.02	%FS
GE _{DRIFT}	Gain Error Temperature Drift			0.3		ppm/°C
DYNAMIC CONVERTER CHARACTERISTICS						
SINAD	Signal-to-Noise Plus Distortion Ratio	$V_{REF} = 2.5\text{ V}$	85	88		dBc
		$V_{REF} = 4.5\text{ V}$ to 5.5 V	89	93.0		dBc
SNR	Signal-to-Noise Ratio	$V_{REF} = 2.5\text{ V}$	85	88		dBc
		$V_{REF} = 4.5\text{ V}$ to 5.5 V	89	93.2		dBc
THD	Total Harmonic Distortion	$V_{REF} = 2.5\text{ V}$		-104		dBc
		$V_{REF} = 4.5\text{ V}$ to 5.5 V		-106		dBc
SFDR	Spurious-Free Dynamic Range	$V_{REF} = 2.5\text{ V}$		108		dBc
		$V_{REF} = 4.5\text{ V}$ to 5.5 V		111		dBc
ENOB	Effective Number of Bits	$V_{REF} = 2.5\text{ V}$	13.8	14.3		bits
		$V_{REF} = 4.5\text{ V}$ to 5.5 V	14.5	15.2		bits
FPBW	-3 dB Full Power Bandwidth	Output at 70.7%FS with FS Differential Input		26		MHz
ANALOG INPUT CHARACTERISTICS						
V _{IN}	Differential Input Range		-V _{REF}		+V _{REF}	V
I _{INA}	Analog Input Current	$\overline{\text{CS}}$ high	-1		1	µA
		$V_{REF} = 5\text{ V}$, $V_{IN} = 0\text{ V}$, $f_S = 50\text{ kSPS}$		3.2		nA
		$V_{REF} = 5\text{ V}$, $V_{IN} = 0\text{ V}$, $f_S = 200\text{ kSPS}$		10.3		nA
C _{INA}	Input Capacitance (+IN or -IN)	In Acquisition Mode		20		pF
		In Conversion Mode		4		pF
CMRR	Common Mode Rejection Ratio	See the Specification Definitions for the test condition		85		dB
DIGITAL INPUT CHARACTERISTICS						
V _{IH}	Input High Voltage	$f_{IN} = 0\text{ Hz}$	$0.7 \times V_{IO}$	1.9		V
V _{IL}	Input Low Voltage	$f_{IN} = 0\text{ Hz}$		1.7	$0.3 \times V_{IO}$	V
I _{IND}	Digital Input Current		-1		1	µA
C _{IND}	Input Capacitance				4	pF

(1) Typical values are at $T_J = 25^\circ\text{C}$ and represent most likely parametric norms. Test limits are specified to AOQL (Average Outgoing Quality Level).

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Converter Electrical Characteristics (continued)

The following specifications apply for $V_A = 4.5\text{ V}$ to 5.5 V , $V_{IO} = 2.7\text{ V}$ to 5.5 V , and $V_{REF} = 2.5\text{ V}$ to 5.5 V for $f_{SCLK} = 1\text{ MHz}$ to 4 MHz or $V_{REF} = 4.5\text{ V}$ to 5.5 V for $f_{SCLK} = 1\text{ MHz}$ to 5 MHz ; $f_{IN} = 20\text{ kHz}$, and $C_L = 25\text{ pF}$, unless otherwise noted. Maximum and minimum values apply for $T_A = T_{MIN}$ to T_{MAX} ; the typical values are tested at $T_A = 25^\circ\text{C}$.⁽¹⁾

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
DIGITAL OUTPUT CHARACTERISTICS						
V_{OH}	Output High Voltage	$I_{SOURCE} = 200\ \mu\text{A}$	$V_{IO} - 0.2$	$V_{IO} - 0.03$		V
		$I_{SOURCE} = 1\ \text{mA}$		$V_{IO} - 0.09$		V
V_{OL}	Output Low Voltage	$I_{SOURCE} = 200\ \mu\text{A}$		0.01	0.4	V
		$I_{SOURCE} = 1\ \text{mA}$		0.07		V
I_{OZH}, I_{OZL}	TRI-STATE Leakage Current	Force 0V or V_A	-1		1	μA
C_{OUT}	TRI-STATE Output Capacitance	Force 0V or V_A		4		pF
	Output Coding		Binary 2's Complement			
POWER SUPPLY CHARACTERISTICS						
V_A	Analog Supply Voltage Range		4.5	5	5.5	V
V_{IO}	Digital Input/Output Supply Voltage Range	(2)	2.7	3	5.5	V
V_{REF}	Reference Voltage Range		0.5	5	V_A	V
I_{VA} (Conv)	Analog Supply Current, Conversion Mode	$V_A = 5\ \text{V}$, $f_{SCLK} = 4\ \text{MHz}$, $f_S = 200\ \text{kSPS}$		1060		μA
		$V_A = 5\ \text{V}$, $f_{SCLK} = 5\ \text{MHz}$, $f_S = 250\ \text{kSPS}$		1160	1340	μA
I_{VIO} (Conv)	Digital I/O Supply Current, Conversion Mode	$V_{IO} = 3\ \text{V}$, $f_{SCLK} = 4\ \text{MHz}$, $f_S = 200\ \text{kSPS}$		80		μA
		$V_{IO} = 3\ \text{V}$, $f_{SCLK} = 5\ \text{MHz}$, $f_S = 250\ \text{kSPS}$		100		μA
I_{VREF} (Conv)	Reference Current, Conversion Mode	$V_A = 5\ \text{V}$, $f_{SCLK} = 4\ \text{MHz}$, $f_S = 200\ \text{kSPS}$		80		μA
		$V_A = 5\ \text{V}$, $f_{SCLK} = 5\ \text{MHz}$, $f_S = 250\ \text{kSPS}$		100	170	μA
I_{VA} (PD)	Analog Supply Current, Power Down Mode (\overline{CS} high)	$f_{SCLK} = 5\ \text{MHz}$, $V_A = 5\ \text{V}$		7		μA
		$f_{SCLK} = 0\ \text{Hz}$, $V_A = 5\ \text{V}$ ⁽³⁾		2	3	μA
I_{VIO} (PD)	Digital I/O Supply Current, Power Down Mode (\overline{CS} high)	$f_{SCLK} = 5\ \text{MHz}$, $V_{IO} = 3\ \text{V}$		1		μA
		$f_{SCLK} = 0\ \text{Hz}$, $V_{IO} = 3\ \text{V}$ ⁽³⁾		0.3	0.5	μA
I_{VREF} (PD)	Reference Current, Power Down Mode (\overline{CS} high)	$f_{SCLK} = 5\ \text{MHz}$, $V_{REF} = 5\ \text{V}$		0.5		μA
		$f_{SCLK} = 0\ \text{Hz}$, $V_{REF} = 5\ \text{V}$ ⁽³⁾		0.5	0.7	μA
PWR (Conv)	Power Consumption, Conversion Mode	$V_A = 5\ \text{V}$, $f_{SCLK} = 4\ \text{MHz}$, $f_S = 200\ \text{kSPS}$, and $f_{IN} = 20\ \text{kHz}$,		5.3		mW
		$V_A = 5\ \text{V}$, $f_{SCLK} = 5\ \text{MHz}$, $f_S = 250\ \text{kSPS}$, and $f_{IN} = 20$		5.8	6.7	mW
PWR (PD)	Power Consumption, Power Down Mode (\overline{CS} high)	$f_{SCLK} = 5\ \text{MHz}$, $V_A = 5.0\ \text{V}$ ⁽³⁾		35		μW
		$f_{SCLK} = 0\ \text{Hz}$, $V_A = 5.0\ \text{V}$ ⁽³⁾		10	15	μW
PSRR	Power Supply Rejection Ratio	See the Specification Definitions for the test condition		-78		dB
AC ELECTRICAL CHARACTERISTICS						
f_{SCLK}	Maximum Clock Frequency		1		5	MHz
f_S	Maximum Sample Rate		(4)50		250	kSPS
t_{ACQ}	Acquisition/Track Time		600			ns
t_{CONV}	Conversion/Hold Time				17	SCLK cycles
t_{AD}	Aperture Delay	See the Specification Definitions		6		ns

(2) The value of V_{IO} is independent of the value of V_A . For example, V_{IO} could be operating at $5.5\ \text{V}$ while V_A is operating at $4.5\ \text{V}$ or V_{IO} could be operating at $2.7\ \text{V}$ while V_A is operating at $5.5\ \text{V}$.

(3) This parameter is ensured by design and/or characterization and is not tested in production.

(4) While the maximum sample rate is $f_{SCLK} / 20$, the actual sample rate may be lower than this by having the \overline{CS} rate slower than $f_{SCLK} / 20$.

6.6 Timing Requirements

The following specifications apply for $V_A = 4.5\text{ V to }5.5\text{ V}$, $V_{IO} = 2.7\text{ V to }5.5\text{ V}$, $V_{REF} = 2.5\text{ V to }5.5\text{ V}$, $f_{SCLK} = 1\text{ Mz to }5\text{ MHz}$, and $C_L = 25\text{ pF}$, unless otherwise noted. Maximum and minimum values apply for $T_A = T_{MIN}$ to T_{MAX} ; the typical values are tested at $T_A = 25^\circ\text{C}$.⁽¹⁾

		MIN	NOM	MAX	UNIT
t_{CSS}	\overline{CS} Setup Time prior to an SCLK rising edge	8	3		ns
t_{CSH}	\overline{CS} Hold Time after an SCLK rising edge	8	3		
t_{DH}	D_{OUT} Hold Time after an SCLK falling edge	6	11		ns
t_{DA}	D_{OUT} Access Time after an SCLK falling edge		18	41	ns
t_{DIS}	D_{OUT} Disable Time after the rising edge of \overline{CS} ⁽²⁾		20	30	ns
t_{CS}	Minimum \overline{CS} Pulse Width	20			ns
t_{EN}	D_{OUT} Enable Time after the 2nd falling edge of SCLK		20	70	ns
t_{CH}	SCLK High Time	20			ns
t_{CL}	SCLK Low Time	20			ns
t_r	D_{OUT} Rise Time		7		ns
t_f	D_{OUT} Fall Time		7		ns

- (1) Typical values are at $T_J = 25^\circ\text{C}$ and represent most likely parametric norms. Test limits are specified to AOQL (Average Outgoing Quality Level).
- (2) t_{DIS} is the time for D_{OUT} to change 10% while being loaded by the Timing Test Circuit.

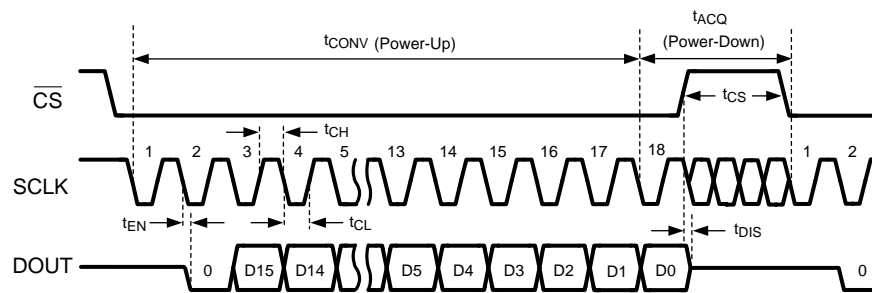


Figure 1. ADC161S626 Single Conversion Timing Diagram

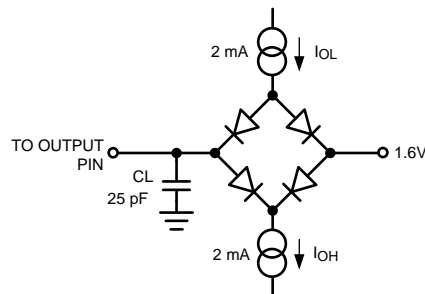


Figure 2. Timing Test Circuit

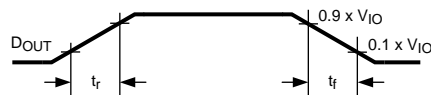
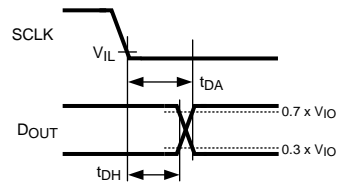
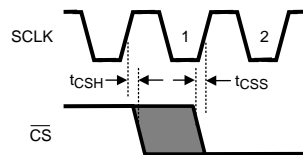
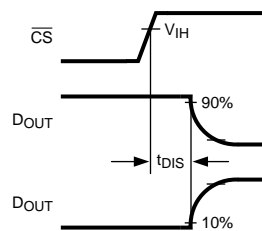


Figure 3. D_{OUT} Rise and Fall Times

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www.ti.com**Figure 4. D_{OUT} Hold and Access Times****Figure 5. Valid \overline{CS} Assertion Times****Figure 6. Voltage Waveform for t_{DIS}**

6.7 Typical Characteristics

$V_A = V_{IO} = V_{REF} = 5\text{ V}$, $f_{SCLK} = 5\text{ MHz}$, $f_{SAMPLE} = 250\text{ kSPS}$, $T_A = +25^\circ\text{C}$, and $f_{IN} = 20\text{ kHz}$ unless otherwise stated.

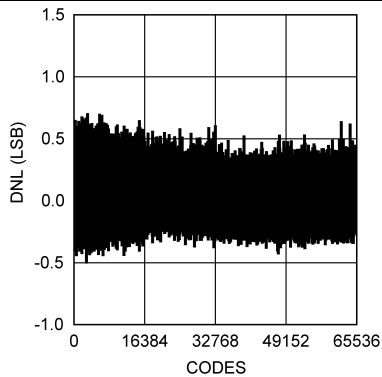


Figure 7. DNL - 250 kSPS

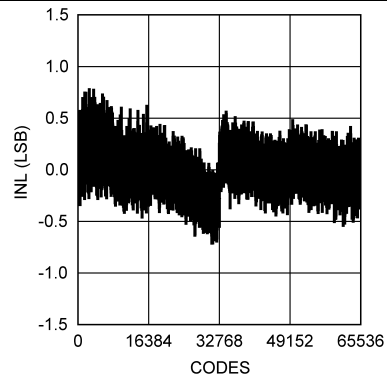


Figure 8. INL - 250 kSPS

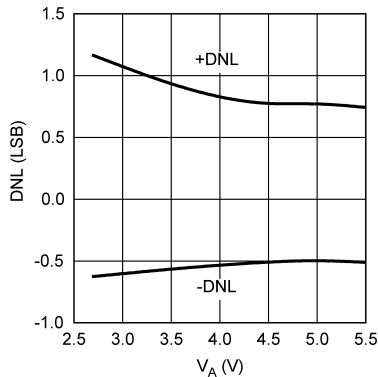


Figure 9. DNL vs. V_A

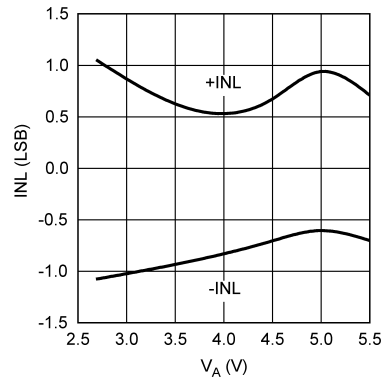


Figure 10. INL vs. V_A

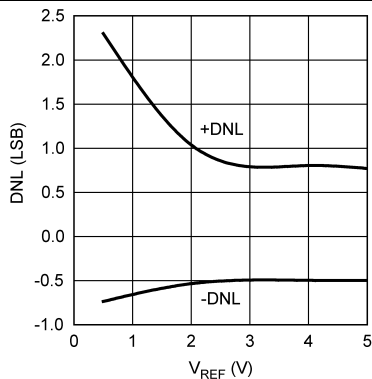


Figure 11. DNL vs. V_{REF}

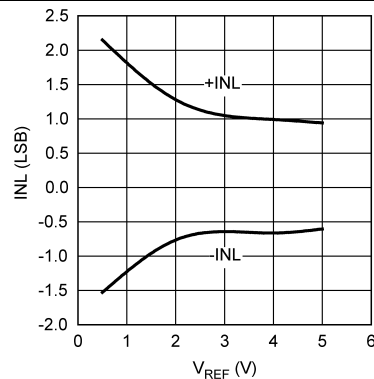


Figure 12. INL vs. V_{REF}

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Typical Characteristics (continued)

$V_A = V_{IO} = V_{REF} = 5\text{ V}$, $f_{SCLK} = 5\text{ MHz}$, $f_{SAMPLE} = 250\text{ kSPS}$, $T_A = +25^\circ\text{C}$, and $f_{IN} = 20\text{ kHz}$ unless otherwise stated.

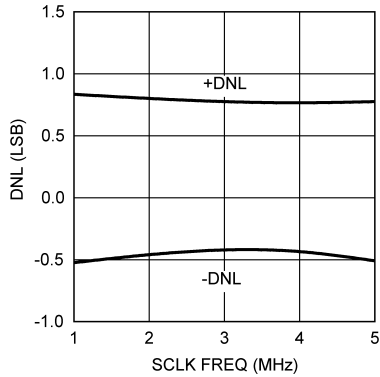


Figure 13. DNL vs. SCLK Frequency

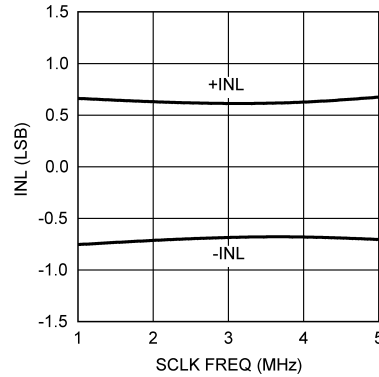


Figure 14. INL vs. SCLK Frequency

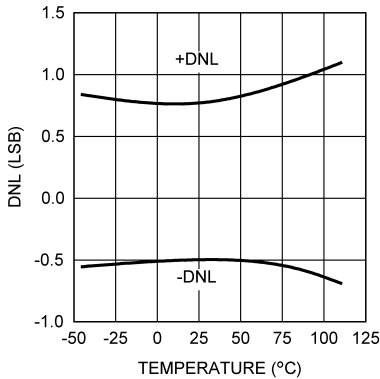


Figure 15. DNL vs. Temperature

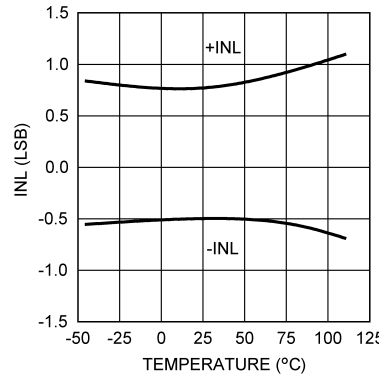


Figure 16. INL vs. Temperature

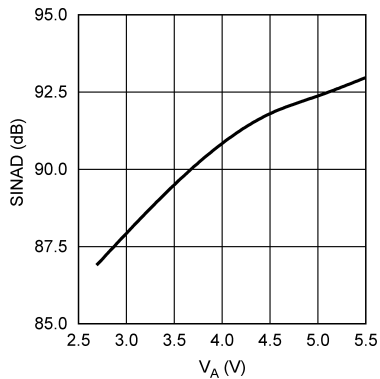


Figure 17. SINAD vs. V_A

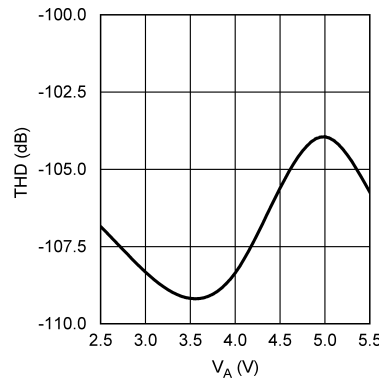


Figure 18. THD vs. V_A

Typical Characteristics (continued)

$V_A = V_{IO} = V_{REF} = 5\text{ V}$, $f_{SCLK} = 5\text{ MHz}$, $f_{SAMPLE} = 250\text{ kSPS}$, $T_A = +25^\circ\text{C}$, and $f_{IN} = 20\text{ kHz}$ unless otherwise stated.

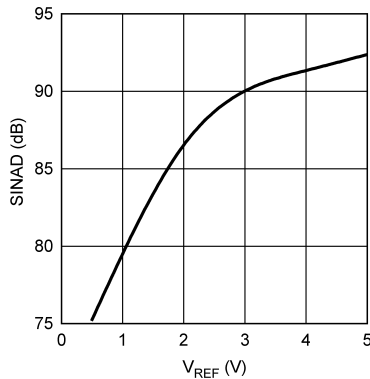


Figure 19. SINAD vs. V_{REF}

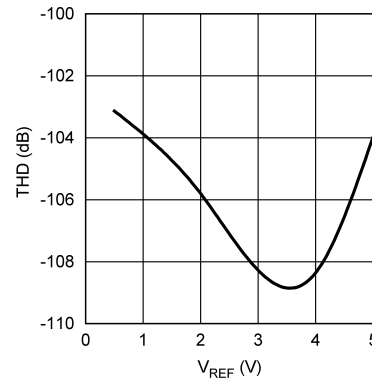


Figure 20. THD vs. V_{REF}

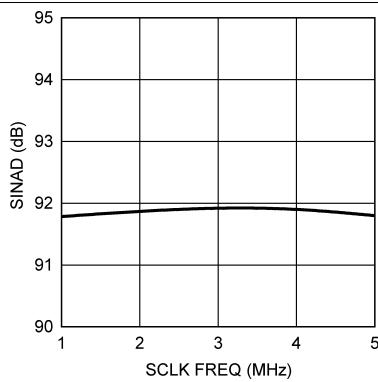


Figure 21. SINAD vs. SCLK Frequency

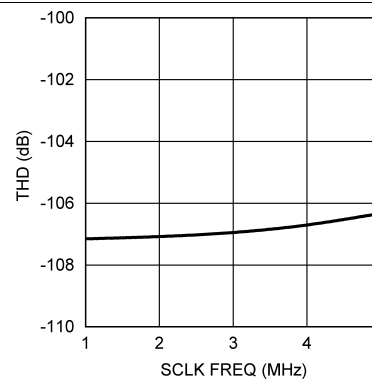


Figure 22. THD vs. SCLK Frequency

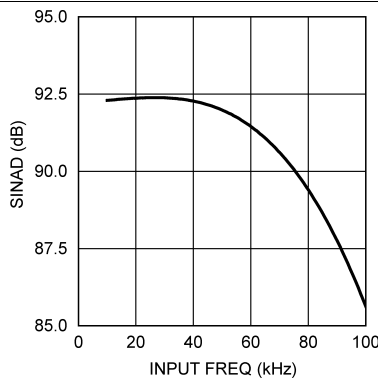


Figure 23. SINAD vs. INPUT Frequency

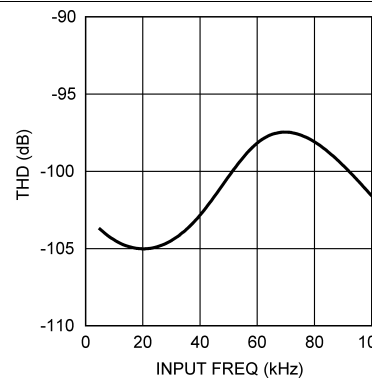
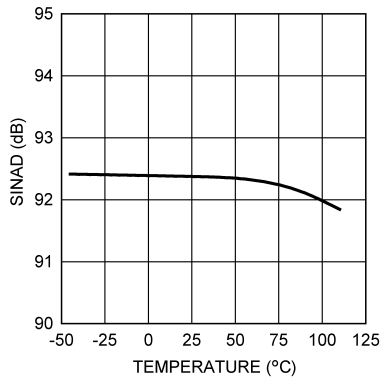
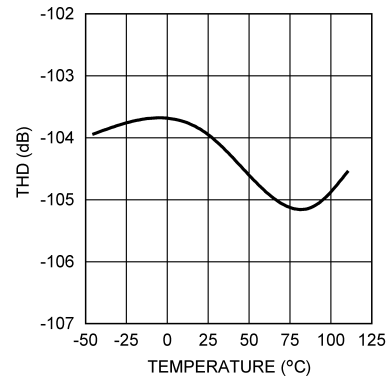
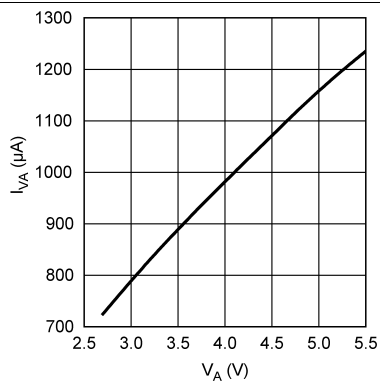
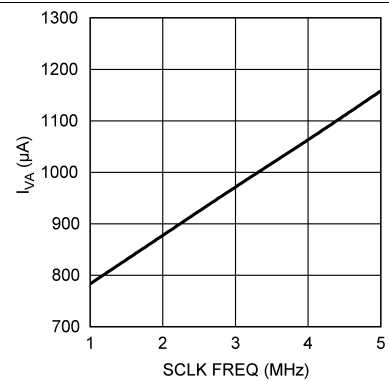
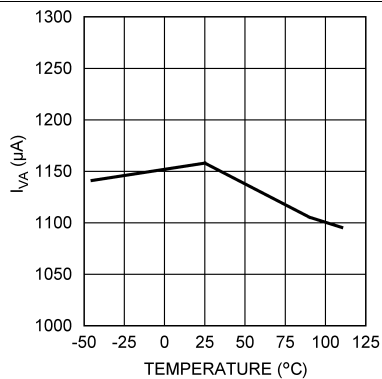
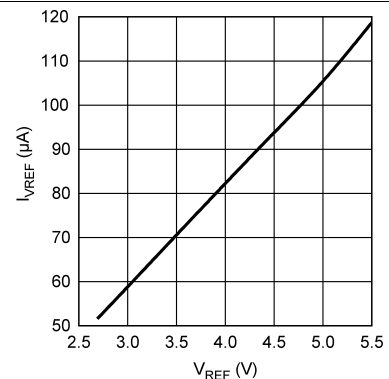


Figure 24. THD vs. INPUT Frequency

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Typical Characteristics (continued)
 $V_A = V_{IO} = V_{REF} = 5\text{ V}$, $f_{SCLK} = 5\text{ MHz}$, $f_{SAMPLE} = 250\text{ kSPS}$, $T_A = +25^\circ\text{C}$, and $f_{IN} = 20\text{ kHz}$ unless otherwise stated.
**Figure 25. SINAD vs. Temperature****Figure 26. THD vs. Temperature****Figure 27. V_A Current vs. V_A** **Figure 28. V_A Current vs. SCLK Frequency****Figure 29. V_A Current vs. Temperature****Figure 30. V_{REF} Current vs. V_{REF}**

Typical Characteristics (continued)

$V_A = V_{IO} = V_{REF} = 5\text{ V}$, $f_{SCLK} = 5\text{ MHz}$, $f_{SAMPLE} = 250\text{ kSPS}$, $T_A = +25^\circ\text{C}$, and $f_{IN} = 20\text{ kHz}$ unless otherwise stated.

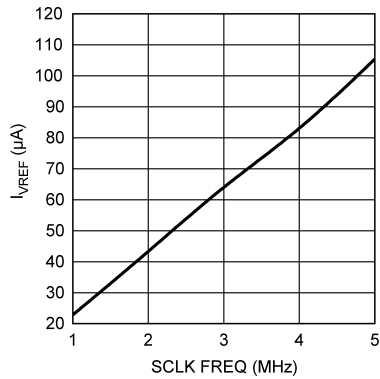


Figure 31. V_{REF} Current vs. SCLK Frequency

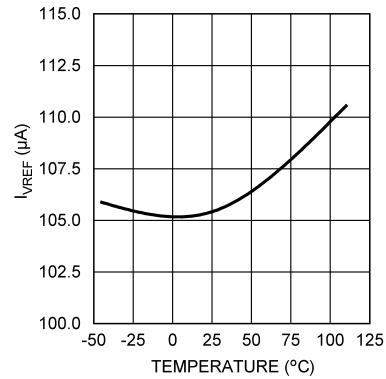


Figure 32. V_{REF} Current vs. Temperature

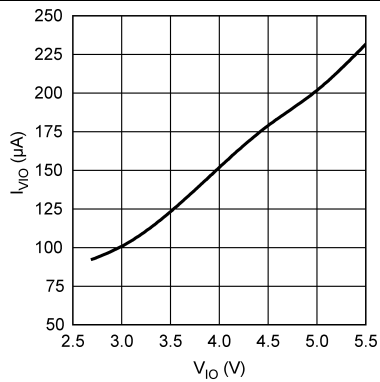


Figure 33. V_{IO} Current vs. V_{IO}

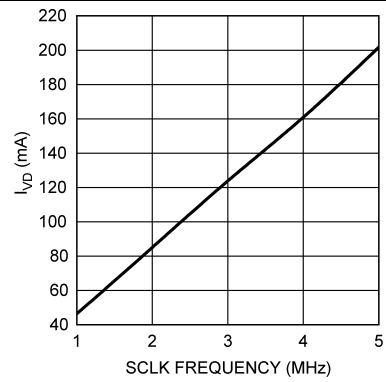


Figure 34. V_{IO} Current vs. SCLK Frequency

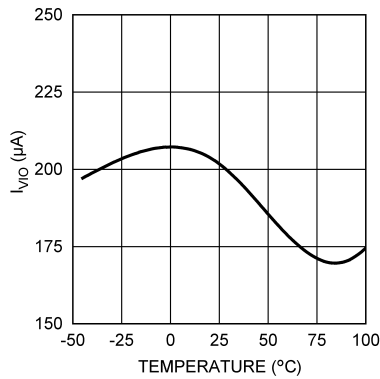


Figure 35. V_{IO} Current vs. Temperature

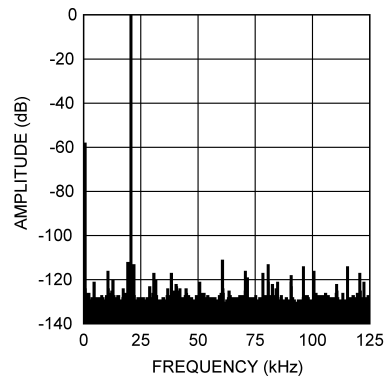
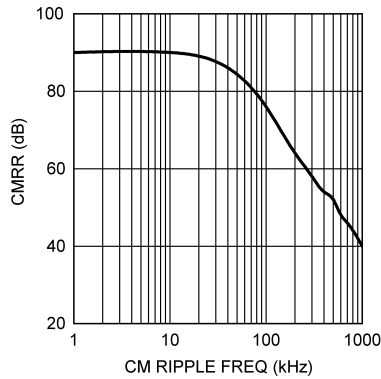
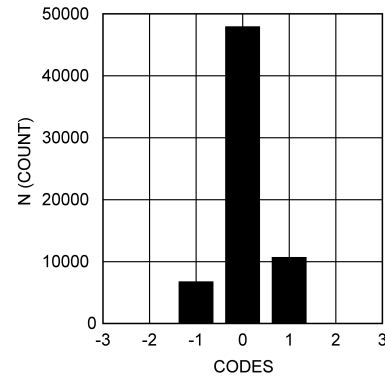
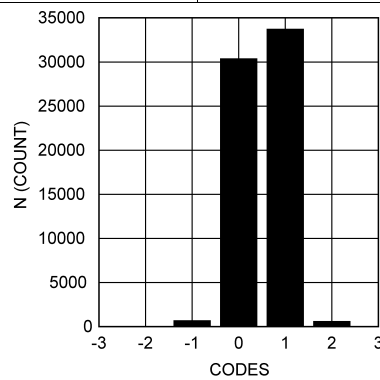


Figure 36. Spectral Response - 250 kSPS

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Typical Characteristics (continued)
 $V_A = V_{IO} = V_{REF} = 5\text{ V}$, $f_{SCLK} = 5\text{ MHz}$, $f_{SAMPLE} = 250\text{ kSPS}$, $T_A = +25^\circ\text{C}$, and $f_{IN} = 20\text{ kHz}$ unless otherwise stated.
**Figure 37. Analog Input CMRR vs. Frequency****Figure 38. Noise Histogram at Code Center****Figure 39. Noise Histogram at Code Transition**

7 Detailed Description

7.1 Overview

The ADC161S626 is a 16-bit, 50 kSPS to 250 kSPS sampling Analog-to-Digital (A/D) converter. The converter uses a successive approximation register (SAR) architecture based upon capacitive redistribution containing an inherent sample-and-hold function. The differential nature of the analog inputs is maintained from the internal sample-and-hold circuits throughout the A/D converter to provide excellent common-mode signal rejection.

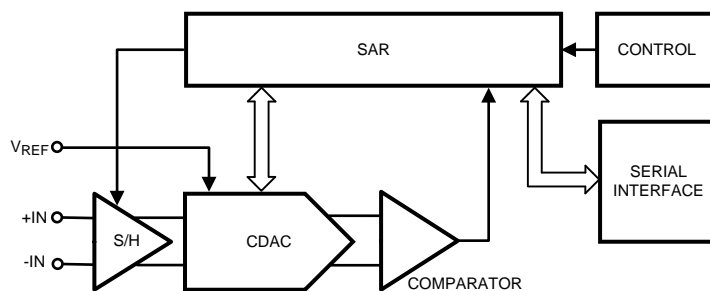
The ADC161S626 operates from independent analog and digital supplies. The analog supply (V_A) can range from 4.5 V to 5.5 V and the digital input/output supply (V_{IO}) can range from 2.7 V to 5.5 V. The ADC161S626 utilizes an external reference (V_{REF}), which can be any voltage between 0.5 V and V_A . The value of V_{REF} determines the range of the analog input, while the reference input current (I_{REF}) depends upon the conversion rate.

The analog input is presented to two input pins: +IN and –IN. Upon initiation of a conversion, the differential input at these pins is sampled on the internal capacitor array. The inputs are disconnected from the internal circuitry while a conversion is in progress. The ADC161S626 features a zero-power track mode (ZPTM) where the ADC is consuming the minimum amount of power (Power-Down Mode) while the internal sampling capacitor array is tracking the applied analog input voltage. The converter enters ZPTM at the end of each conversion window and experiences no delay when the ADC enters into Conversion Mode. This feature allows the user an easy means for optimizing system performance based on the settling capability of the analog source while minimizing power consumption. ZPTM is exercised by bringing chip select bar (\overline{CS}) high or when \overline{CS} is held low after the conversion is complete (after the 18th falling edge of the serial clock).

The ADC161S626 communicates with other devices via a Serial Peripheral Interface (SPI), a synchronous serial interface that operates using three pins: chip select bar (\overline{CS}), serial clock (SCLK), and serial data out (D_{OUT}). The external SCLK controls data transfer and serves as the conversion clock. The duty cycle of SCLK is essentially unimportant, provided the minimum clock high and low times are met. The minimum SCLK frequency is set by internal capacitor leakage. Each conversion requires a minimum of 18 SCLK cycles to complete. If less than 16 bits of conversion data are required, \overline{CS} can be brought high at any point during the conversion. This procedure of terminating a conversion prior to completion is commonly referred to as short cycling.

The digital conversion result is clocked out by the SCLK input and is provided serially, most significant bit (MSB) first, at the D_{OUT} pin. The digital data that is provided at the D_{OUT} pin is that of the conversion currently in progress and thus there is no pipe line delay or latency.

7.2 Functional Block Diagram



7.3 Feature Description

7.3.1 Reference Input (V_{REF})

The externally supplied reference voltage (V_{REF}) sets the analog input range. The ADC161S626 will operate with V_{REF} in the range of 0.5 V to V_A .

Operation with V_{REF} below 2.5V is possible with slightly diminished performance. As V_{REF} is reduced, the range of acceptable analog input voltages is reduced. Assuming a proper common-mode input voltage (V_{CM}), the differential peak-to-peak input range is limited to $(2 \times V_{REF})$.

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Feature Description (continued)

Reducing V_{REF} also reduces the size of the least significant bit (LSB). For example, the size of one LSB is equal to $[(2 \times V_{REF}) / 2^n]$, which is $152.6 \mu\text{V}$ where n is 16 bits and V_{REF} is 5V. When the LSB size goes below the noise floor of the ADC161S626, the noise will span an increasing number of codes and overall performance will suffer. Dynamic signals will have their SNR degrade; while, D.C. measurements will have their code uncertainty increase. Since the noise is Gaussian in nature, the effects of this noise can be reduced by averaging the results of a number of consecutive conversions.

V_{REF} and analog inputs (+IN and -IN) are connected to the capacitor array through a switch matrix when the input is sampled. Hence, I_{REF} , I_{+IN} , and I_{-IN} are a series of transient spikes that occur at a frequency dependent on the operating sample rate of the ADC161S626.

I_{REF} changes only slightly with temperature. See the curves, “Reference Current vs. SCLK Frequency” and “Reference Current vs. Temperature” in the [Typical Characteristics](#) section for additional details.

7.3.2 Sample and Hold

The ADC161S626 has a differential input where the effective input voltage that is digitized is (+IN) – (–IN).

7.3.2.1 Input Settling

When the ADC161S626 enters acquisition (t_{ACQ}) mode at the end of the conversion window, the internal sampling capacitor (C_{SAMPLE}) is connected to the ADC input via an internal switch and a series resistor (R_{SAMPLE}), as shown in [Figure 40](#). Typical values for C_{SAMPLE} and R_{SAMPLE} are 20 pF and 200 ohms respectively. If there is not a large external capacitor (C_{EXT}) at the analog input of the ADC, a voltage spike will be observed at the input pins. This is a result of C_{SAMPLE} and C_{EXT} being at different voltage potentials. The magnitude and direction of the voltage spike depend on the difference between the voltage of C_{SAMPLE} and C_{EXT} . If the voltage at C_{SAMPLE} is greater than the voltage at C_{EXT} , a positive voltage spike will occur. If the opposite is true, a negative voltage spike will occur. It is not critical for the performance of the ADC161S626 to filter out the voltage spike. Rather, ensure that the transient of the spike settles out within t_{ACQ} .

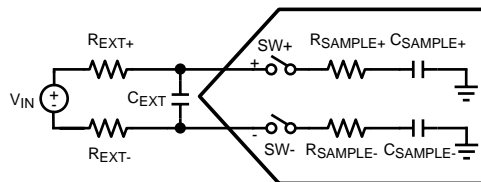


Figure 40. ADC Input Capacitors

7.3.3 Serial Digital Interface

The ADC161S626 communicates via a synchronous 3-wire serial interface as shown in [Figure 1](#) or re-shown in [Figure 41](#) for convenience. \overline{CS} , chip select bar, initiates conversions and frames the serial data transfers. SCLK (serial clock) controls both the conversion process and the timing of the serial data. D_{OUT} is the serial data output pin, where a conversion result is sent as a serial data stream, MSB first.

A serial frame is initiated on the falling edge of \overline{CS} and ends on the rising edge of \overline{CS} . The ADC161S626's D_{OUT} pin is in a high impedance state when \overline{CS} is high and for the first clock period after \overline{CS} is asserted; D_{OUT} is active for the remainder of time when \overline{CS} is asserted.

The ADC161S626 samples the differential input upon the assertion of \overline{CS} . Assertion is defined as bringing the \overline{CS} pin to a logic low state. For the first 17 periods of the SCLK following the assertion of \overline{CS} , the ADC161S626 is converting the analog input voltage. On the 18th falling edge of SCLK, the ADC161S626 enters acquisition (t_{ACQ}) mode. For the next three periods of SCLK, the ADC161S626 is operating in acquisition mode where the ADC input is tracking the analog input signal applied across +IN and -IN. During acquisition mode, the ADC161S626 is consuming a minimal amount of power.

Feature Description (continued)

The ADC161S626 can enter conversion mode (t_{CONV}) under three different conditions. The first condition involves \overline{CS} going low (asserted) with SCLK high. In this case, the ADC161S626 enters conversion mode on the first falling edge of SCLK after \overline{CS} is asserted. In the second condition, \overline{CS} goes low with SCLK low. Under this condition, the ADC161S626 automatically enters conversion mode and the falling edge of \overline{CS} is seen as the first falling edge of SCLK. In the third condition, \overline{CS} and SCLK go low simultaneously and the ADC161S626 enters conversion mode. While there is no timing restriction with respect to the falling edges of \overline{CS} and SCLK, there are minimum setup and hold time requirements for the falling edge of \overline{CS} with respect to the rising edge of SCLK. See [Figure 5](#) in the [Timing Requirements](#) section for more information.

7.3.3.1 \overline{CS} Input

The \overline{CS} (chip select bar) input is active low and is CMOS compatible. The ADC161S626 enters conversion mode when \overline{CS} is asserted and the SCLK pin is in a logic low state. When \overline{CS} is high, the ADC161S626 is always in acquisition mode and thus consuming the minimum amount of power. Since \overline{CS} must be asserted to begin a conversion, the sample rate of the ADC161S626 is equal to the assertion rate of \overline{CS} .

Proper operation requires that the fall of \overline{CS} not occur simultaneously with a rising edge of SCLK. If the fall of \overline{CS} occurs during the rising edge of SCLK, the data might be clocked out one bit early. Whether or not the data is clocked out early depends upon how close the \overline{CS} transition is to the SCLK transition, the device temperature, and the characteristics of the individual device. To ensure that the MSB is always clocked out at a given time (the 3rd falling edge of SCLK), it is essential that the fall of \overline{CS} always meet the timing requirement specified in the [Timing Requirements](#) table.

7.3.3.2 SCLK Input

The SCLK (serial clock) is used as the conversion clock to shift out the conversion result. SCLK is CMOS compatible. Internal settling time requirements limit the maximum clock frequency while internal capacitor leakage limits the minimum clock frequency. The ADC161S626 offers ensured performance with the clock rates indicated in the electrical table.

The ADC161S626 enters acquisition mode on the 18th falling edge of SCLK during a conversion frame. Assuming that the LSB is clocked into a controller on the 18th rising edge of SCLK, there is a minimum acquisition time period that must be met before a new conversion frame can begin. Other than the 18th rising edge of SCLK that was used to latch the LSB into a controller, there is no requirement for the SCLK to transition during acquisition mode. Therefore, it is acceptable to idle SCLK after the LSB has been latched into the controller.

7.3.3.3 Data Output

The data output format of the ADC161S626 is two's complement as shown in [Figure 42](#). This figure indicates the ideal output code for a given input voltage and does not include the effects of offset, gain error, linearity errors, or noise. Each data output bit is output on the falling edges of SCLK. D_{OUT} is in a high impedance state for the 1st falling edge of SCLK while the 2nd SCLK falling edge clocks out a leading zero. The 3rd to 18th SCLK falling edges clock out the conversion result, MSB first.

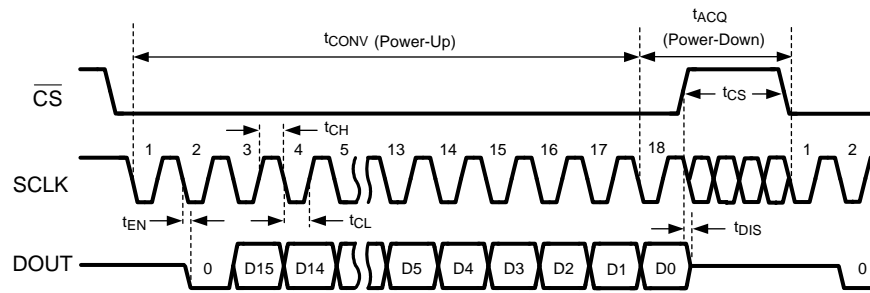
While most receiving systems will capture the digital output bits on the rising edges of SCLK, the falling edges of SCLK may be used to capture the conversion result if the minimum hold time for D_{OUT} is acceptable. See [Figure 4](#) for D_{OUT} hold (t_{DH}) and access (t_{DA}) times.

D_{OUT} is enabled on the second falling edge of SCLK after the assertion of \overline{CS} and is disabled on the rising edge of \overline{CS} . If \overline{CS} is raised prior to the 18th falling edge of SCLK, the current conversion is aborted and D_{OUT} will go into its high impedance state. A new conversion will begin when \overline{CS} is driven LOW.

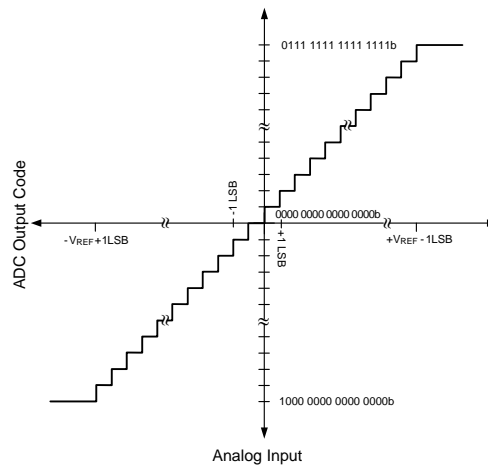
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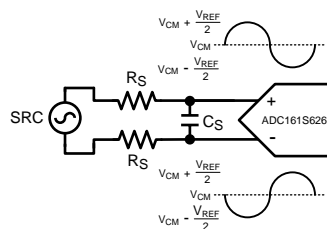
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Feature Description (continued)**Figure 41. ADC161S626 Single Conversion Timing Diagram****7.4 Device Functional Modes****7.4.1 Differential Input Operation**

The transfer curve of the ADC161S626 for a fully differential input signal is shown in [Figure 42](#). A positive full scale output code (0111 1111 1111 1111b or 7FFFh or 32,767d) will be obtained when $(+IN) - (-IN)$ is greater than or equal to $(V_{REF} - 1 \text{ LSB})$. A negative full scale code (1000 0000 0000 0000b or 8000h or -32,768d) will be obtained when $[(+IN) - (-IN)]$ is less than or equal to $(-V_{REF} + 1 \text{ LSB})$. This ignores gain, offset and linearity errors, which will affect the exact differential input voltage that will determine any given output code.

**Figure 42. ADC Transfer Curve**

Both inputs should be biased at a common mode voltage (V_{CM}), which will be thoroughly discussed in [Figure 43](#) shows the ADC161S626 being driven by a full-scale differential source.

**Figure 43. Differential Input**

Device Functional Modes (continued)

The allowable input common mode voltage (V_{CM}) range depends upon V_A and V_{REF} used for the ADC161S626. The ranges of V_{CM} are depicted in Figure 44 and Figure 46. Note that these figures only apply to a V_A of 5V. Equations for calculating the minimum and maximum V_{CM} for differential and single-ended operations are shown in Figure 44.

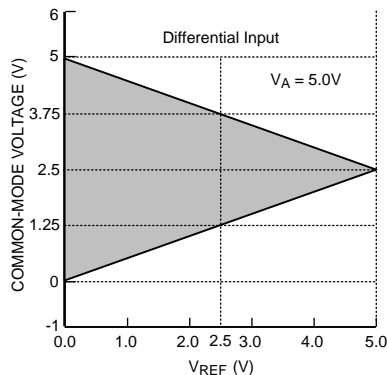


Figure 44. V_{CM} range for Differential Input operation

7.4.2 Single-Ended Input Operation

For single-ended operation, the non-inverting input (+IN) of the ADC161S626 can be driven with a signal that has a peak-to-peak range that is equal to or less than $(2 \times V_{REF})$. The inverting input (-IN) should be biased at a stable V_{CM} that is halfway between these maximum and minimum values. In order to utilize the entire dynamic range of the ADC161S626, V_{REF} is limited to $(V_A / 2)$. This allows +IN a maximum swing range of ground to V_A . Figure 45 shows the ADC161S626 being driven by a full-scale single-ended source.

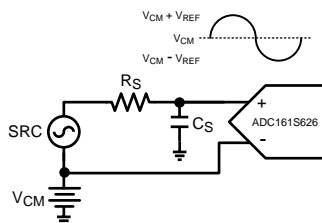


Figure 45. Single-Ended Input

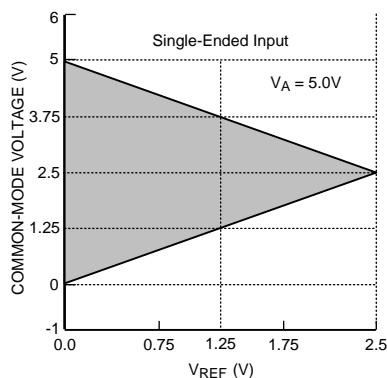


Figure 46. V_{CM} Range for single-Ended Operation

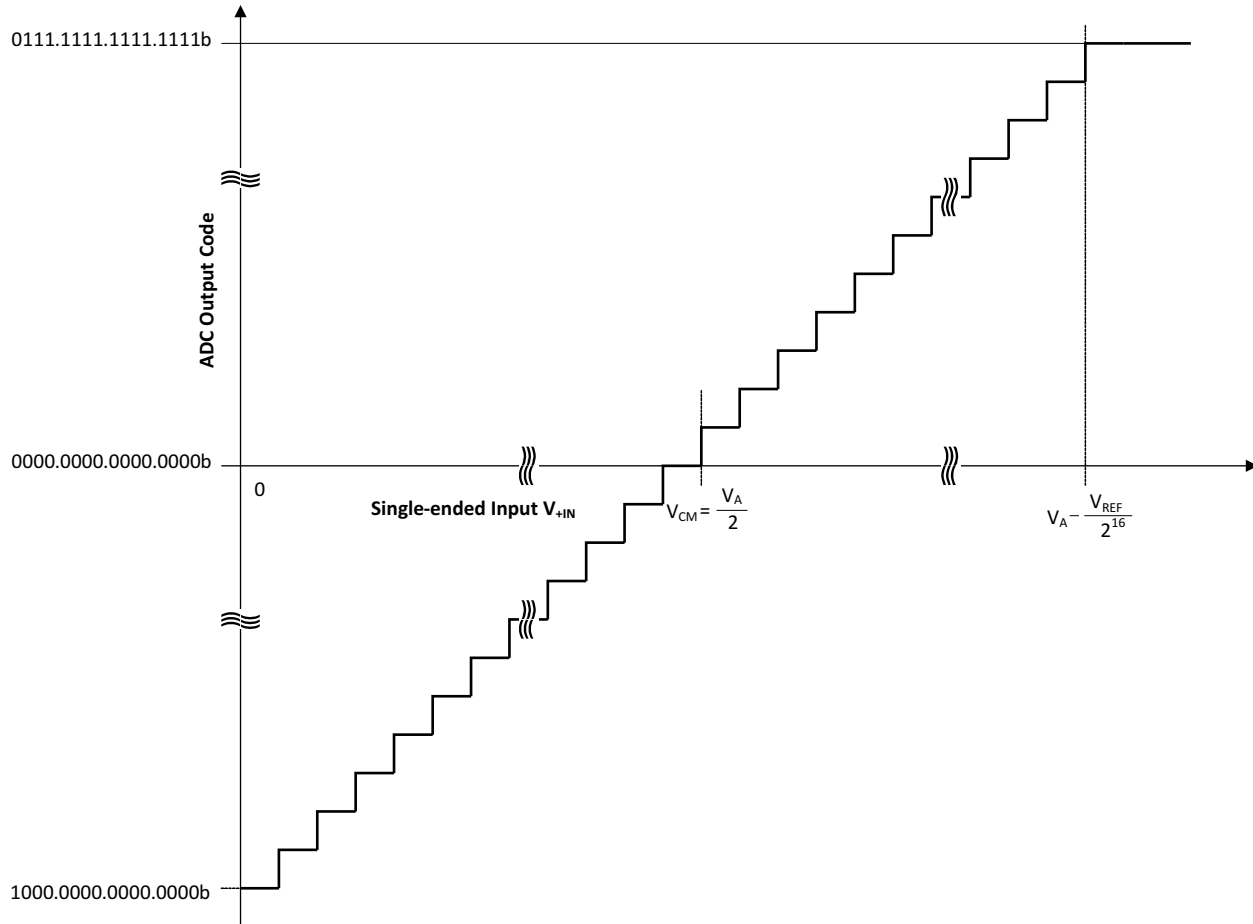
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Device Functional Modes (continued)

Since the design of the ADC161S626 is optimized for a differential input, the performance degrades slightly when driven with a single-ended input. Linearity characteristics such as INL and DNL typically degrade by 0.1 LSB and dynamic characteristics such as SINAD typically degrade by 2 dB. Note that single-ended operation should only be used if the performance degradation (compared with differential operation) is acceptable.

**Figure 47. Single-Ended Transfer Characteristic****7.4.3 Short Cycling**

Short cycling refers to the process of halting a conversion after the last needed bit is outputted. Short cycling can be used to lower the power consumption in those applications that do not need a full 16-bit resolution, or where an analog signal is being monitored until some condition occurs. In some circumstances, the conversion could be terminated after the first few bits. This will lower power consumption in the converter since the ADC161S626 spends more time in acquisition mode and less time in conversion mode.

Short cycling is accomplished by pulling \overline{CS} high after the last required bit is received from the ADC161S626 output. This is possible because the ADC161S626 places the latest converted data bit on D_{OUT} as it is generated. If only 10-bits of the conversion result are needed, for example, the conversion can be terminated by pulling \overline{CS} high after the 10th bit has been clocked out.

Device Functional Modes (continued)

7.4.4 Burst Mode Operation

Normal operation of the ADC161S626 requires the SCLK frequency to be 20 times the sample rate and the \overline{CS} rate to be the same as the sample rate. However, in order to minimize power consumption in applications requiring sample rates below 250 kSPS, the ADC161S626 should be run with an SCLK frequency of 5 MHz and a \overline{CS} rate as slow as the system requires. When this is accomplished, the ADC161S626 is operating in burst mode. The ADC161S626 enters into acquisition mode at the end of each conversion, minimizing power consumption. This causes the converter to spend the longest possible time in acquisition mode. Since power consumption scales directly with conversion rate, minimizing power consumption requires determining the lowest conversion rate that will satisfy the requirements of the system.

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8 Application and Implementation**NOTE**

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

The following sections outline the design principles of data acquisition system based on the ADC161S626.

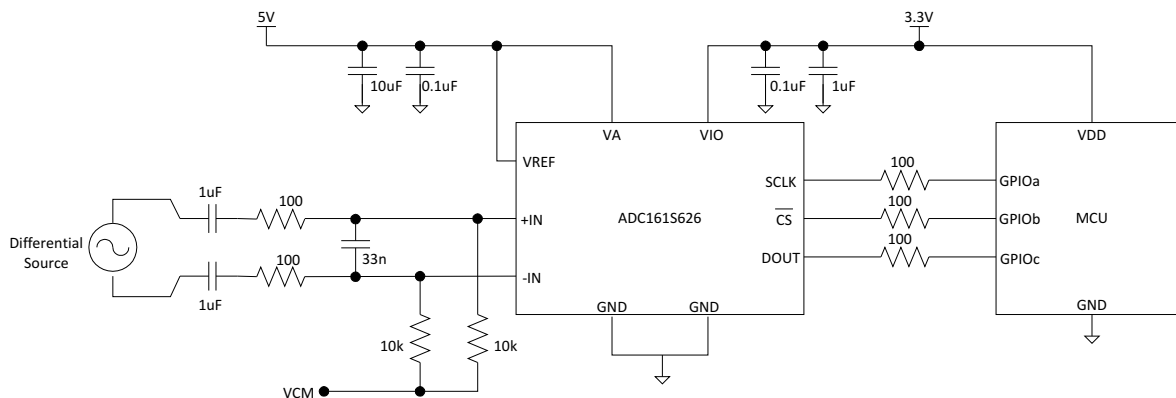
8.2 Typical Application

Figure 48. Low Cost, Low Power Data Acquisition System

Figure 48 shows a typical connection diagram for the ADC161S626 operating at V_A of 5 V. V_{REF} is connected to a 2.5-V shunt reference, the LM4020-2.5, to define the analog input range of the ADC161S626 independent of supply variation on the 5-V supply line. The V_{REF} pin should be de-coupled to the ground plane by a 0.1- μ F ceramic capacitor and a tantalum capacitor of 10 μ F. It is important that the 0.1- μ F capacitor be placed as close as possible to the V_{REF} pin while the placement of the tantalum capacitor is less critical. It is also recommended that the V_A and V_{IO} pins of the ADC161S626 be de-coupled to ground by a 0.1- μ F ceramic capacitor in parallel with a 10- μ F tantalum capacitor.

8.2.1 Design Requirements

A positive supply only data acquisition system capable of digitizing differential signals ranging from -5 V to 5 V ($V_{+IN} - V_{-IN}$), $BW = 10$ kHz, and a throughput of 250 kSPS (F_s).

The ADC161S626 has to interface to an MCU whose supply is set at 3.3 V.

8.2.2 Detailed Design Procedure

The signal range requirement forces the design to use 5 V as V_{REF} potential. This, in turn, forces the V_A to be no less than 5 V as well.

The requirement of interfacing to the MCU which is powered by 3.3-V supply, forces the choice of 3.3 V as a V_D supply.

Sampling is in fact a modulation process which may result in aliasing of the input signal, if the input signal is not adequately band limited. In order to avoid the aliasing the Nyquist criterion has to be met:

$$BW_{\text{signal}} \leq \frac{F_s}{2} = 125\text{kHz} \quad (1)$$

Therefore it is necessary to place an anti-aliasing filter at the input of the ADC. The filter may be single pole low pass filter whose pole location has to satisfy:

Typical Application (continued)

$$\frac{1}{2\pi \times R \times C} \leq \frac{F_s}{2} \quad (2)$$

$$R \times C \geq \frac{1}{\pi \times F_s} \quad (3)$$

With $F_s = 250$ kHz, a good choice for the single pole filter is:

$$R = 100$$

$$C = 33 \text{ nF}$$

This reduces the input $BW_{\text{signal}} = 48$ kHz.

The capacitor at the inputs of the device provides not only the filtering of the input signal, but it also absorbs the charge kick-back from the ADC. The kick-back is the result of the internal switches opening at the end of the acquisition period.

The common mode level of the ADC inputs has to be set by the external bias source. The VCM bias has to be isolated from the inputs by a large resistance in order to avoid input signal attenuation.

The VA and VIO sources are already separated in this example, due to the design requirements. This also benefits the overall performance of the ADC, as the potentially noisy VIO supply does not contaminate the VA. In the same vein, further consideration could be given to the SPI interface, especially when the master MCU is capable of producing fast rising edges on the digital bus signals. Inserting small resistances in the digital signal path may help in reducing the ground bounce, and thus improve the overall noise performance of the system.

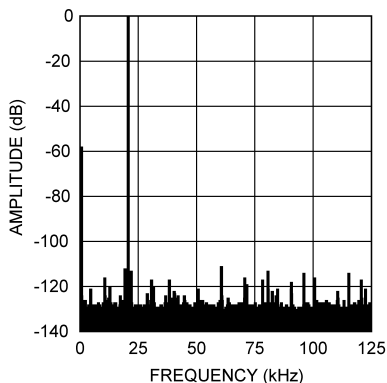
8.2.3 Application Curve

Figure 49. Spectral Response

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9 Power Supply Recommendations

9.1 Analog and Digital Power Supplies

Any ADC architecture is sensitive to spikes on the power supply, reference, and ground pins. These spikes may originate from switching power supplies, digital logic, high power devices, and other sources. Power to the ADC161S626 should be clean and well bypassed. A 0.1 μF ceramic bypass capacitor and a 1 μF to 10 μF capacitor should be used to bypass the ADC161S626 supply, with the 0.1 μF capacitor placed as close to the ADC161S626 package as possible.

Since the ADC161S626 has both the V_A and V_{IO} pins, the user has three options on how to connect these pins. The first option is to tie V_A and V_{IO} together and power them with the same power supply. This is the most cost effective way of powering the ADC161S626 but is also the least ideal. As stated previously, noise from V_{IO} can couple into V_A and adversely affect performance. The other two options involve the user powering V_A and V_{IO} with separate supply voltages. These supply voltages can have the same amplitude or they can be different. V_A can be set to any value between +4.5V and +5.5V; while V_{IO} can be set to any value between +2.7V and +5.5V.

Best performance will typically be achieved with V_A operating at 5V and V_{IO} at 3V. Operating V_A at 5V offers the best linearity and dynamic performance when V_{REF} is also set to 5V; while operating V_{IO} at 3V reduces the power consumption of the digital logic. Operating the digital interface at 3V also has the added benefit of decreasing the noise created by charging and discharging the capacitance of the digital interface pins.

9.2 Voltage Reference

The reference source must have a low output impedance and needs to be bypassed with a minimum capacitor value of 0.1 μF . A larger capacitor value of 1 μF to 10 μF placed in parallel with the 0.1 μF is preferred. While the ADC161S626 draws very little current from the reference on average, there are higher instantaneous current spikes at the reference.

V_{REF} of the ADC161S626, like all A/D converters, does not reject noise or voltage variations. Keep this in mind if V_{REF} is derived from the power supply. Any noise and/or ripple from the supply that is not rejected by the external reference circuitry will appear in the digital results. The use of an active reference source is recommended. The LM4040 and LM4050 shunt reference families and the LM4120 and LM4140 series reference families are excellent choices for a reference source.

10 Layout

10.1 Layout Guidelines

Capacitive coupling between the noisy digital circuitry and the sensitive analog circuitry can lead to poor performance. The solution is to keep the analog circuitry separated from the digital circuitry and the clock line as short as possible. Digital circuits create substantial supply and ground current transients. The logic noise generated could have significant impact upon system noise performance. To avoid performance degradation of the ADC161S626 due to supply noise, avoid using the same supply for the V_A and V_{REF} of the ADC161S626 that is used for digital circuitry on the board.

Generally, analog and digital lines should cross each other at 90° to avoid crosstalk. However, to maximize accuracy in high resolution systems, avoid crossing analog and digital lines altogether. It is important to keep clock lines as short as possible and isolated from ALL other lines, including other digital lines. In addition, the clock line should also be treated as a transmission line and be properly terminated. The analog input should be isolated from noisy signal traces to avoid coupling of spurious signals into the input. Any external component (e.g., a filter capacitor) connected between the converter's input pins and ground or to the reference input pin and ground should be connected to a very clean point in the ground plane.

A single, uniform ground plane and the use of split power planes are recommended. The power planes should be located within the same board layer. All analog circuitry (input amplifiers, filters, reference components, etc.) should be placed over the analog power plane. All digital circuitry should be placed over the digital power plane. Furthermore, the GND pins on the ADC161S626 and all the components in the reference circuitry and input signal chain that are connected to ground should be connected to the ground plane at a quiet point. Avoid connecting these points too close to the ground point of a microprocessor, microcontroller, digital signal processor, or other high power digital device.

Layout Guidelines (continued)

For best performance, care should be taken with the physical layout of the printed circuit board. This is especially true with a low V_{REF} or when the conversion rate is high. At high clock rates there is less time for settling, so it is important that any noise settles out before the conversion begins.

10.2 Layout Example

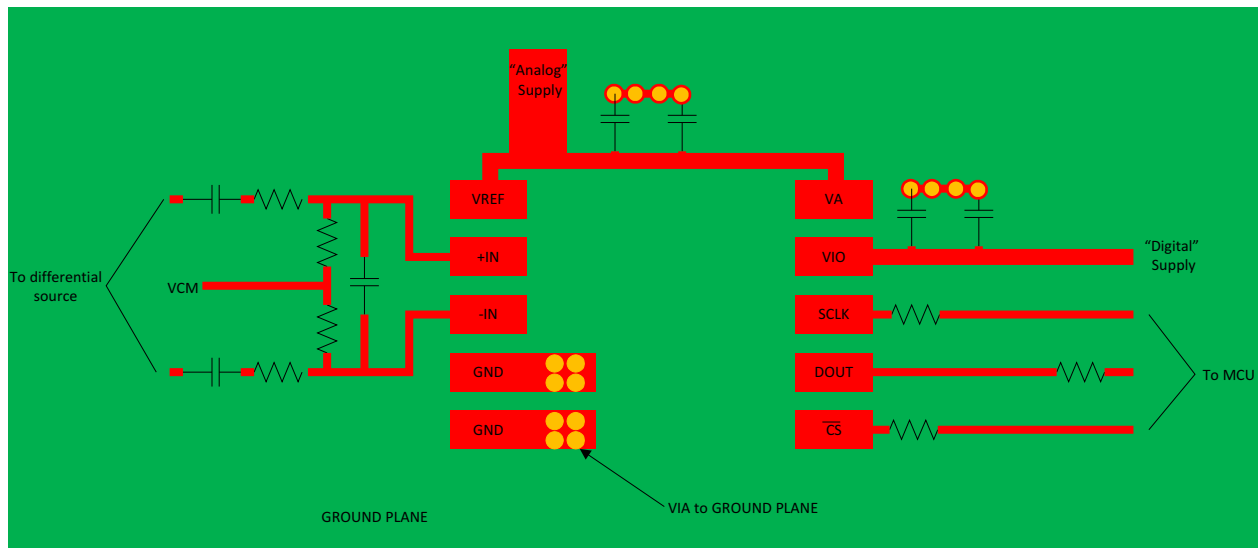


Figure 50. PCB Layout Example

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11 Device and Documentation Support**11.1 Device Support****11.1.1 Specification Definitions**

APERTURE DELAY is the time between the first falling edge of SCLK and the time when the input signal is sampled for conversion.

COMMON MODE REJECTION RATIO (CMRR) is a measure of how well in-phase signals common to both input pins are rejected.

To calculate CMRR, the change in output offset is measured while the common mode input voltage is changed from 2V to 3V.

$$\text{CMRR} = 20 \text{ LOG} (\Delta \text{ Common Input} / \Delta \text{ Output Offset}) \quad (4)$$

CONVERSION TIME is the time required, after the input voltage is acquired, for the ADC to convert the input voltage to a digital word.

DIFFERENTIAL NON-LINEARITY (DNL) is the measure of the maximum deviation from the ideal step size of 1 LSB.

DUTY CYCLE is the ratio of the time that a repetitive digital waveform is high to the total time of one period. The specification here refers to the SCLK.

EFFECTIVE NUMBER OF BITS (ENOB, or EFFECTIVE BITS) is another method of specifying Signal-to-Noise and Distortion or SINAD. ENOB is defined as $(\text{SINAD} - 1.76) / 6.02$ and says that the converter is equivalent to a perfect ADC of this (ENOB) number of bits.

FULL POWER BANDWIDTH is a measure of the frequency at which the reconstructed output fundamental drops 3 dB below its low frequency value for a full scale input.

GAIN ERROR is the deviation from the ideal slope of the transfer function. It is the difference between Positive Full-Scale Error and Negative Full-Scale Error and can be calculated as:

$$\text{Gain Error} = \text{Positive Full-Scale Error} - \text{Negative Full-Scale Error} \quad (5)$$

INTEGRAL NON-LINEARITY (INL) is a measure of the deviation of each individual code from a line drawn from $\frac{1}{2}$ LSB below the first code transition through $\frac{1}{2}$ LSB above the last code transition. The deviation of any given code from this straight line is measured from the center of that code value.

MISSING CODES are those output codes that will never appear at the ADC outputs. The ADC161S626 is ensured not to have any missing codes.

NEGATIVE FULL-SCALE ERROR is the difference between the differential input voltage at which the output code transitions from code 0x8001h to 0x8000h and $-V_{\text{REF}} + 1 \text{ LSB}$.

NEGATIVE GAIN ERROR is the difference between the negative full-scale error and the offset error.

OFFSET ERROR is the difference between the differential input voltage at which the output code transitions from code 0x0000h to 0x0001h and 1 LSB.

POSITIVE FULL-SCALE ERROR is the difference between the differential input voltage at which the output code transitions from code 0xFFFFh to 0xFFFEh and $V_{\text{REF}} - 1 \text{ LSB}$.

POSITIVE GAIN ERROR is the difference between the positive full-scale error and the offset error.

POWER SUPPLY REJECTION RATIO (PSRR) is a measure of how well a change in the analog supply voltage is rejected. PSRR is calculated from the ratio of the change in offset error for a given change in supply voltage, expressed in dB. For the ADC161S626, V_A is changed from 4.5V to 5.5V.

$$\text{PSRR} = 20 \text{ LOG} (\Delta \text{Output Offset} / \Delta V_A) \quad (6)$$

SIGNAL TO NOISE PLUS DISTORTION (S/N+D or SINAD) is the ratio, expressed in dB, of the rms value of the input signal to the rms value of all of the other spectral components below one-half the sampling frequency, including harmonics but excluding d.c.

SIGNAL TO NOISE RATIO (SNR) is the ratio, expressed in dB, of the rms value of the input signal to the rms value of the sum of all other spectral components below one-half the sampling frequency, not

Device Support (continued)

including harmonics or d.c.

SPURIOUS FREE DYNAMIC RANGE (SFDR) is the difference, expressed in dB, between the desired signal amplitude to the amplitude of the peak spurious spectral component below one-half the sampling frequency, where a spurious spectral component is any signal present in the output spectrum that is not present at the input and may or may not be a harmonic.

THROUGHPUT TIME is the minimum time required between the start of two successive conversions.

TOTAL HARMONIC DISTORTION (THD) is the ratio of the rms total of the first five harmonic components at the output to the rms level of the input signal frequency as seen at the output, expressed in dB. THD is calculated as

$$\text{THD} = 20 \times \log_{10} \sqrt{\frac{A_{f_2}^2 + \dots + A_{f_6}^2}{A_{f_1}^2}}$$

where

- A_{f_1} is the RMS power of the input frequency at the output
- A_{f_2} through A_{f_6} are the RMS power in the first 5 harmonic frequencies. (7)

11.2 Trademarks

QSPI is a trademark of Motorola.

MICROWIRE is a trademark of National Semiconductor Corp.

All other trademarks are the property of their respective owners.

11.3 Electrostatic Discharge Caution

These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

11.4 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
ADC161S626C1MM/NO.A	Active	Production	VSSOP (DGS) 10	1000 SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 85	X98C
ADC161S626C1MM/NO.B	Active	Production	VSSOP (DGS) 10	1000 SMALL T&R	-	Call TI	Call TI	-40 to 85	
ADC161S626C1MM/NOPB	Active	Production	VSSOP (DGS) 10	1000 SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 85	X98C
ADC161S626C1MME/NO.A	Active	Production	VSSOP (DGS) 10	250 SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 85	X98C
ADC161S626C1MME/NO.B	Active	Production	VSSOP (DGS) 10	250 SMALL T&R	-	Call TI	Call TI	-40 to 85	
ADC161S626C1MME/NOPB	Active	Production	VSSOP (DGS) 10	250 SMALL T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 85	X98C
ADC161S626C1MMX/NO.A	Active	Production	VSSOP (DGS) 10	3500 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 85	X98C
ADC161S626C1MMX/NO.B	Active	Production	VSSOP (DGS) 10	3500 LARGE T&R	-	Call TI	Call TI	-40 to 85	
ADC161S626C1MMX/NOPB	Active	Production	VSSOP (DGS) 10	3500 LARGE T&R	Yes	SN	Level-1-260C-UNLIM	-40 to 85	X98C

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

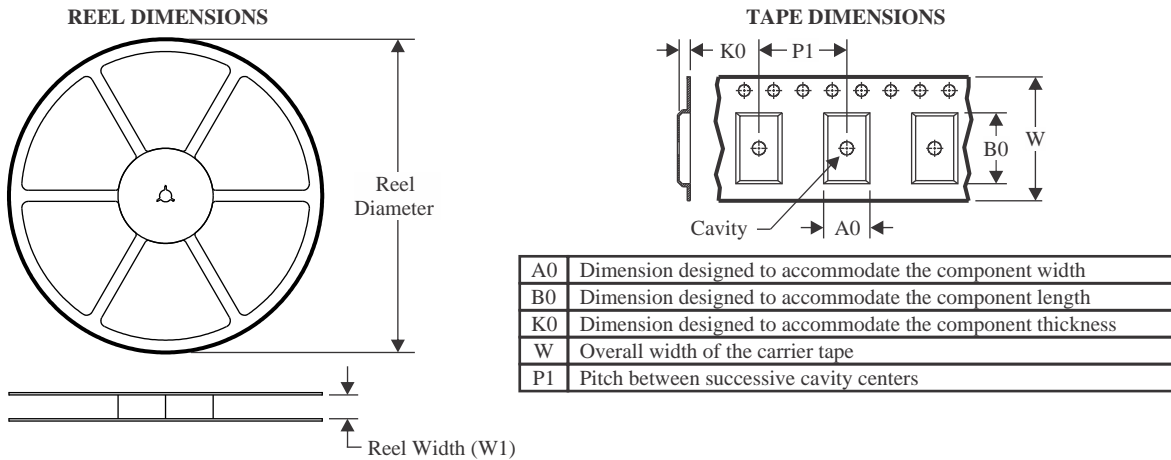
Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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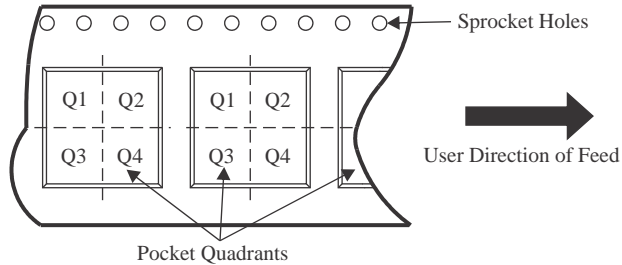
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TAPE AND REEL INFORMATION



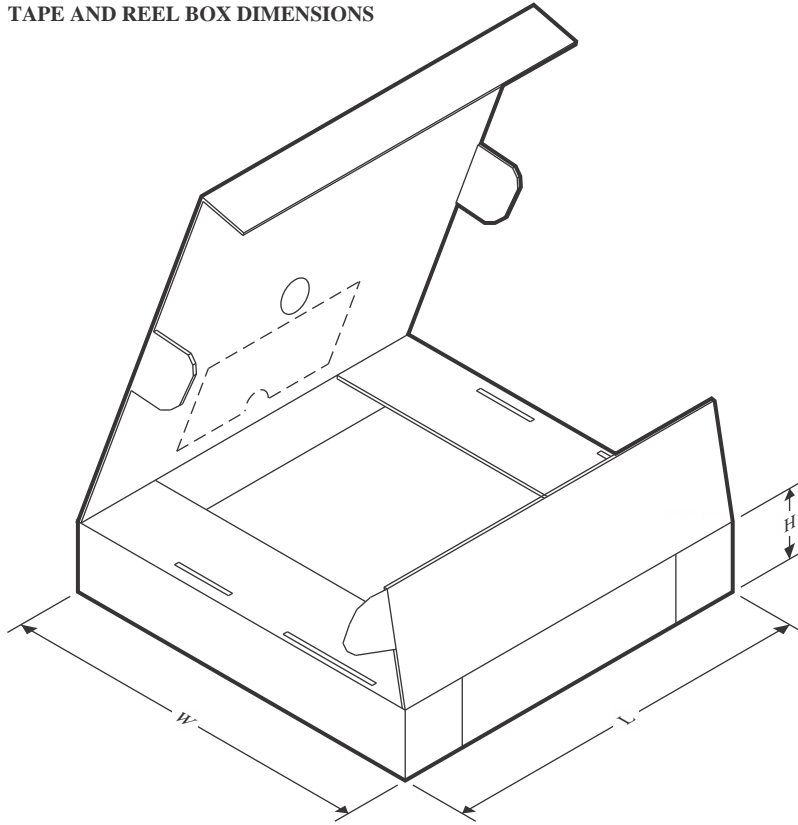
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ADC161S626C1MM/NOPB	VSSOP	DGS	10	1000	177.8	12.4	5.3	3.4	1.4	8.0	12.0	Q1
ADC161S626C1MME/NOPB	VSSOP	DGS	10	250	177.8	12.4	5.3	3.4	1.4	8.0	12.0	Q1
ADC161S626C1MMX/NOPB	VSSOP	DGS	10	3500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ADC161S626C1MM/NOPB	VSSOP	DGS	10	1000	210.0	185.0	35.0
ADC161S626C1MME/ NOPB	VSSOP	DGS	10	250	210.0	185.0	35.0
ADC161S626C1MMX/ NOPB	VSSOP	DGS	10	3500	367.0	367.0	35.0

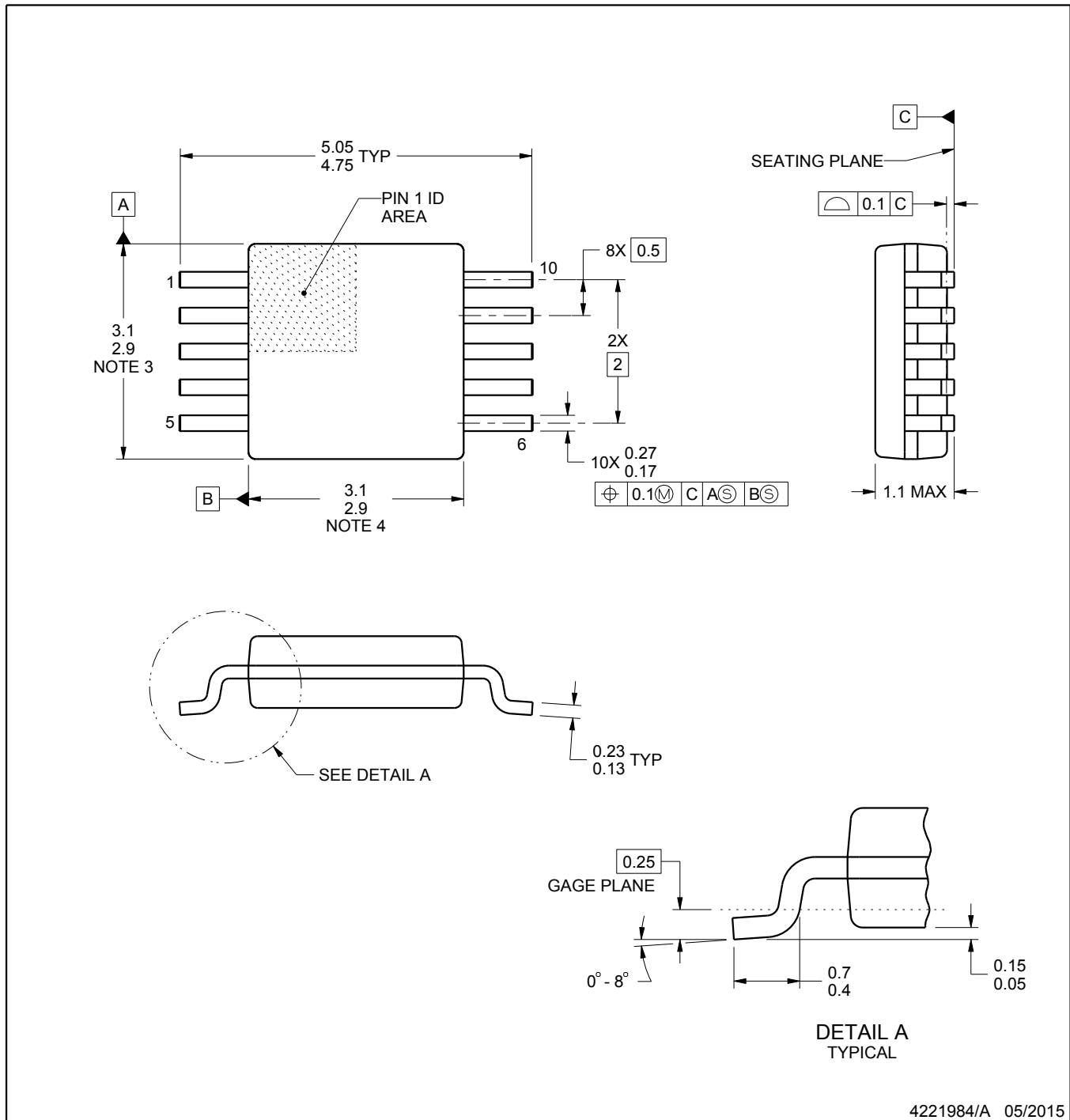


DGS0010A

PACKAGE OUTLINE

VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



NOTES:

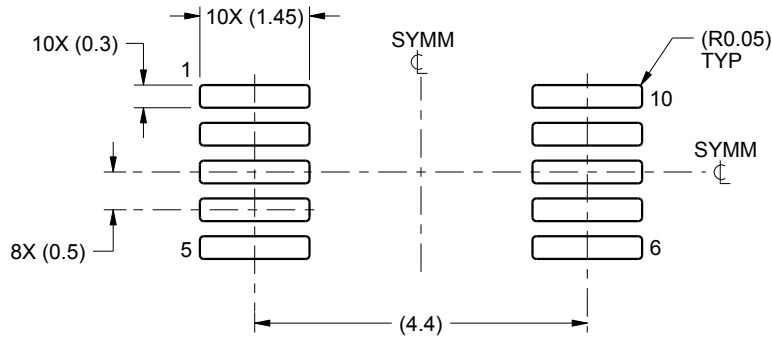
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-187, variation BA.

EXAMPLE BOARD LAYOUT

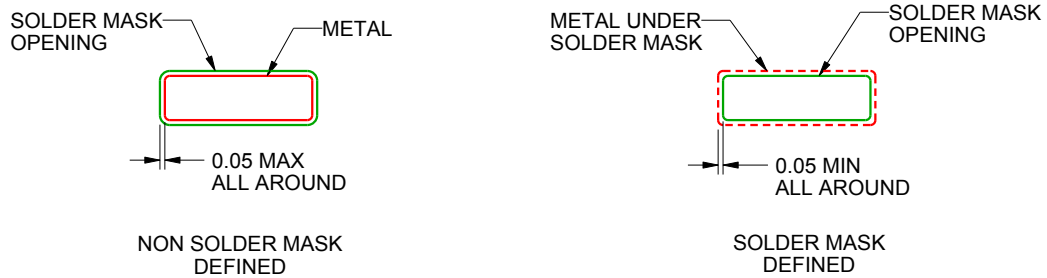
DGS0010A

VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
SCALE:10X



SOLDER MASK DETAILS
NOT TO SCALE

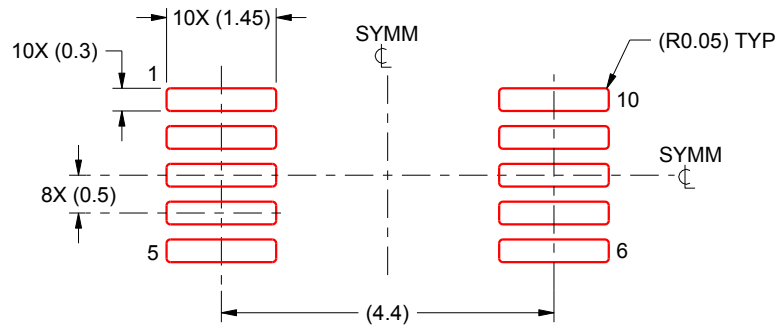
4221984/A 05/2015

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN**DGS0010A****VSSOP - 1.1 mm max height**

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
 BASED ON 0.125 mm THICK STENCIL
 SCALE:10X

4221984/A 05/2015

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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